

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination CLAUDE ET AL.	
		Examiner Daniel Kim	Art Unit 2185	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,602,789	02-1997	Endoh et al.	365/185.03
*	B	US-5,781,485	07-1998	Lee et al.	365/201
*	C	US-20040139074	07-2004	Epstein, Avi	707/6
*	D	US-6,762,951	07-2004	Itoh et al.	365/149
*	E	US-6,989,861	01-2006	Schinner, Charles E.	348/231.6
*	F	US-6,628,542	09-2003	Hayashi et al.	365/158
*	G	US-6,075,738	06-2000	Takano, Yoh	365/210
*	H	US-5,546,578	08-1996	Takada, Hiroshi	707/5
*	I	US-5,812,491	09-1998	Shinozaki et al.	365/233
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.